











SN74HC595B

ZHCSER0-MARCH 2016

## SN74HC595B 采用三态输出寄存器的 8 位移位寄存器

## 特性

- 8 位串行输入/并行输出移位寄存器
- 采用超小型逻辑四方扁平无引线 (QFN) 封装 (最大 高度为 0.5mm)
- 独立于 Vcc 的输入过压容差
- 2V 至 6V 的宽运行电压范围
- 高电流三态输出最多可驱动 15 个低功耗肖特基晶 体管-晶体管逻辑器件 (LSTTL) 负载
- 低功耗: I<sub>CC</sub> 为 80µA(最大值)
- t<sub>pd</sub> = 13ns ( 典型值 )
- ±6mA 输出驱动(电压为 5V 时)
- 低输入电流:1µA(最大值)
- 移位寄存器具有直接清零功能
- 运行温度为 -55°C 至 125°C

## 2 应用

- 网络交换机
- 工厂自动化
- 移动可穿戴设备
- 工业楼宇自动化
- 电力基础设施
- 发光二极管 (LED) 显示屏
- 服务器

## 3 说明

SN74HC595B 器件包含一个 8 位串行输入/并行输出 移位寄存器,可将数据馈入 8 位 D 类存储寄存器。存 储寄存器具有并行三态输出。移位寄存器和存储寄存器 均具有独立时钟。移位寄存器具有一个直接覆盖清零 (SRCLR) 输入以及用于级联结构的串行 (SER) 输入和 串行输出。当输出使能 (OE) 输入置为高电平时,除 Q<sub>H</sub> 之外的所有输出均将置于高阻抗状态。

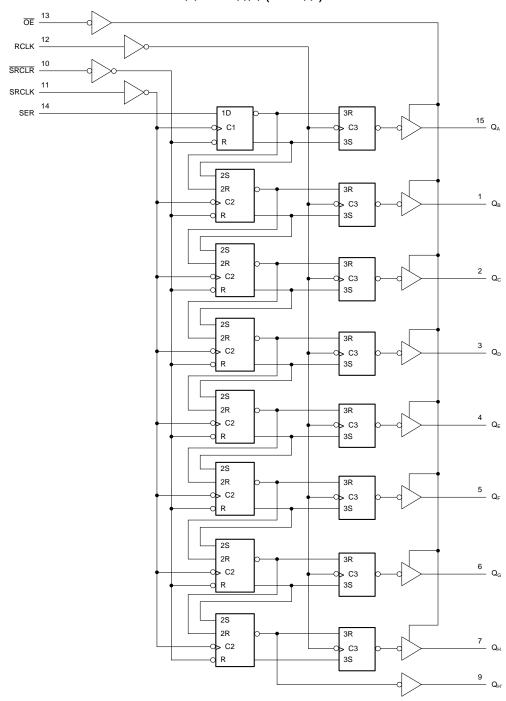
### 表 1. 器件信息

部件号	封装(引脚)	封装尺寸(标称值)
SN74HC595BRWN	X1QFN (16)	2.50mm x 2.50mm

(1) 要了解所有可用封装,请参见数据表末尾的可订购产品附录。



图 1. 逻辑图(正逻辑)





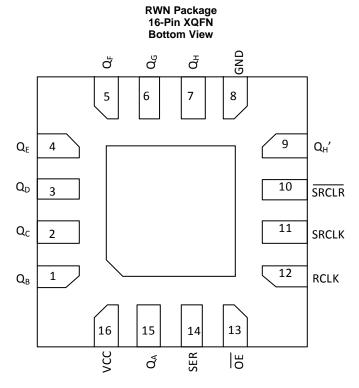
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# 4 Pin Configuration and Functions



**Table 2. Pin Functions** 

PIN		1/0	DECODINE	
NAME	RWN	I/O	DESCRIPTION	
GND	8	_	Ground Pin	
ŌĒ	13	I	Output Enable; does not control Q <sub>H</sub>	
Q <sub>A</sub>	15	0	Q <sub>A</sub> Output	
$Q_B$	1	0	Q <sub>B</sub> Output	
$Q_{\mathbb{C}}$	2	0	Q <sub>C</sub> Output	
$Q_D$	3	0	Q <sub>D</sub> Output	
Q <sub>E</sub>	4	0	Q <sub>E</sub> Output	
$Q_{F}$	5	0	Q <sub>F</sub> Output	
$Q_G$	6	0	Q <sub>G</sub> Output	
Q <sub>H</sub>	7	0	Q <sub>H</sub> Output	
Q <sub>H</sub> '	9	0	Q <sub>H</sub> Output	
RCLK	12	I	RCLK Input	
SER	14	I	SER Input	
SRCLK	11	I	SRCLK Input	
SRCLR	10	I	SRCLR Input	
V <sub>CC</sub>	16	_	Power Pin	



# 5 Specifications

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### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage		-0.5	7	V
VI	Input voltage		-0.5	7	V
I <sub>IK</sub>	Input clamp current <sup>(1)</sup>	V <sub>I</sub> < 0		-20	mA
I <sub>OK</sub>	Output clamp current (2)	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
Io	Continuous output current	$V_O = 0$ to $V_{CC}$		±35	mA
	Continuous current through V <sub>CC</sub> or GND			±70	mA
TJ	Junction temperature			150	°C
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 5.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1)	±2000	
$V_{(ESD)}$	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	±1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			SN	74HC595B		LINUT
			MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2	5	6	V
		V <sub>CC</sub> = 2 V	1.5			
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 4.5 V	3.15			V
		V <sub>CC</sub> = 6 V	4.2			
		V <sub>CC</sub> = 2 V			0.5	
$V_{IL}$	Low-level input voltage	V <sub>CC</sub> = 4.5 V			1.35	V
		V <sub>CC</sub> = 6 V			1.8	
VI	Input voltage		0		V <sub>CC</sub>	V
Vo	Output voltage		0		$V_{CC}$	V
		V <sub>CC</sub> = 2 V			1000	V
Δt/Δν	Input transition rise or fall time (2)	V <sub>CC</sub> = 4.5 V			500	ns
		V <sub>CC</sub> = 6 V			400	
T <sub>A</sub>	Operating free-air temperature		-55		125	°C

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. See the TI application report, *Implications of Slow or Floating CMOS Inputs*, SCBA004.

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> If this device is used in the threshold region (from V<sub>IL</sub>max = 0.5 V to V<sub>IH</sub> min = 1.5 V), there is a potential to go into the wrong state from induced grounding, causing double clocking. Operating with the inputs at t<sub>t</sub> = 1000 ns and V<sub>CC</sub> = 2 V does not damage the device; however, functionally, the CLK inputs are not ensured while in the shift, count, or toggle operating modes.





## 5.4 Thermal Information

	THERMAL METRIC <sup>(1)</sup>	SN74HC595B RWN (X1QFN)	UNIT
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	112	
$R_{\theta JCtop}$	Junction-to-case (top) thermal resistance	47.9	
$R_{\theta JB}$	Junction-to-board thermal resistance	72.4	°C/W
ΨЈТ	Junction-to-top characterization parameter	0.6	C/VV
ΨЈВ	Junction-to-board characterization parameter	72.4	
$R_{\theta JCbot}$	Junction-to-case (bottom) thermal resistance	32.2	

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

## 5.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEO	F CONDITIONS	V	Т	<sub>A</sub> = 25°C		T <sub>A</sub> = -55°C to	o 125°C	T <sub>A</sub> = -40°C	to 85°C	LINUT
PARAMETER	IES	T CONDITIONS	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		1.9		
		$I_{OH} = -20 \mu A$	4.5 V	4.4	4.499		4.4		4.4		
			6 V	5.9	5.999		5.9		5.9		
V <sub>OH</sub>	$V_I = V_{IH} \text{ or } V_{IL}$	$Q_{H'}$ , $I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		V
		$Q_A - Q_H$ , $I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		
		$Q_{H'}$ , $I_{OH} = -5.2 \text{ mA}$	6 V	5.48	5.8		5.2		5.34		
		$Q_A - Q_H$ , $I_{OH} = -7.8 \text{ mA}$	6 V	5.48	5.8		5.2		5.34		V V nA μA
			2 V		0.002	0.1		0.1		0.1 0.1 0.1	
		$I_{OL} = 20 \mu A$	4.5 V		0.001	0.1		0.1			
			6 V		0.001	0.1		0.1			
V <sub>OL</sub>	$V_I = V_{IH}$ or $V_{IL}$	$Q_{H'}$ , $I_{OL} = 4 \text{ mA}$	4.5 V		0.17	0.26		0.4		0.33	V
		$Q_A - Q_H$ , $I_{OL} = 6 \text{ mA}$	4.5 V		0.17	0.26		0.4		0.33	
		$Q_{H'}$ , $I_{OL} = 5.2 \text{ mA}$	6 V		0.15	0.26		0.4		0.33	
		$Q_A - Q_H, I_{OL} = 7.8 \text{ mA}$	6 V		0.15	0.26		0.4		0.33	
I <sub>I</sub>	$V_I = V_{CC}$ or 0		6 V		±0.1	±100		±1000		±1000	nA
I <sub>OZ</sub>	$V_O = V_{CC}$ or 0, $Q_A - Q_H$		6 V		±0.01	±0.5		±10		±5	μA
Icc	$V_I = V_{CC}$ or 0, $I_C$	, = 0	6 V			8		160		80	μA
C <sub>i</sub>			2 V to 6 V		3	10		10		10	pF



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# 5.6 Timing Requirements

over operating free-air temperature range (unless otherwise noted)

			.,	$T_A = 25^{\circ}C$ $T_A = -55^{\circ}C$ to 125°C		125°C	$T_A = -40$ °C to 85°C			
			V <sub>CC</sub>	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		6		4.2		5	
f <sub>clock</sub>	Clock freque	ncy	4.5 V		31		21		25	MHz
			6 V		36		25		MAX 5 25 N	
			2 V	80		120		100		
		SRCLK or RCLK high or low	4.5 V	16		24		20		
	Pulse		6 V	14		20		17	5 25 MHz	
t <sub>w</sub>	duration		2 V	80		120		100		ns
		SRCLR low	4.5 V	16		24		20		
				6 V	14		20		17	
			2 V	100		150		125		
		SER before SRCLK↑	4.5 V	20		30		25		
			6 V	17		25		21		
		SRCLK↑ before RCLK↑ <sup>(1)</sup>	2 V	75		113		94		ļ
			4.5 V	15		23		19		
	Cat up time		6 V	13		19		16		20
t <sub>su</sub>	Set-up time		2 V	50		75		65		ns
		SRCLR low before RCLK↑	4.5 V	10		15		13		
			6 V	9		13		11		
			2 V	50		75		60		
		SRCLR high (inactive) before SRCLK↑	4.5 V	10		15		12		
		DEIDIE SKOLK	6 V	9		13		11		
			2 V	0		0		0		
t <sub>h</sub>	Hold time, SI	ER after SRCLK↑	4.5 V	0		0		0		ns
			6 V	0		0		0		

<sup>(1)</sup> This set-up time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

## 5.7 Switching Characteristics

Over recommended operating free-air temperature range.

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	V <sub>CC</sub>	T,	<sub>\(\pi\)</sub> = 25°	С	T <sub>A</sub> = -55 125°	S°C to	T <sub>A</sub> = -40 85°0	°C to	UNIT
	(INPUT)	(001701)	CAPACITANCE		MIN	TYP	MAX	MIN	MAX	MIN	MAX	
				2 V	6	26		4.2		5		
f <sub>max</sub>			50 pF	4.5 V	31	38		21		25		MHz
				6 V	36	42		25		29		
				2 V		50	160		240		200	
	SRCLK	$Q_{H'}$	50 pF	4.5 V		17	32		48		40	
				6 V		14	27		41		34	20
t <sub>pd</sub>				2 V		50	150		225		187	ns
	RCLK	$Q_A - Q_H$	50 pF	4.5 V		17	30		45		37	
				6 V		14	26		38		32	
				2 V		51	175		261		219	
t <sub>PHL</sub>	SRCLR	$Q_{H'}$	50 pF	4.5 V		18	35		52		44	ns
				6 V		15	30		44		37	
				2 V		40	150		255		187	
t <sub>en</sub>	ŌĒ	$Q_A - Q_H$	50 pF	4.5 V		15	30		45		37	ns
				6 V		13	26		38		32	
				2 V		42	200		300		250	250
t <sub>dis</sub>	ŌĒ	$Q_A - Q_H$	50 pF	4.5 V		23	40		60		50	ns
				6 V		20	34		51		43	
				2 V		28	60		90		75	
		$Q_A - Q_H$	50 pF	4.5 V		8	12		18		15	
				6 V		6	10		15		13	
t <sub>t</sub>				2 V		28	75		110		95	ns
		$Q_{H'}$	50 pF	4.5 V		8	15		22		19	
				6 V		6	13		19		16	
				2 V		60	200		300		250	
t <sub>pd</sub>	RCLK	$Q_A - Q_H$	150 pf	4.5 V		22	40		60		50	ns
-				6 V		19	34		51		43	
				2 V		70	200		298		250	
t <sub>en</sub>	ŌĒ	$Q_A - Q_H$	150 pf	4.5 V		23	40		60		50	ns
-		1	-	6 V		19	34		51		43	
				2 V		45	210		315		265	
t <sub>t</sub>		$Q_A - Q_H$	150 pf	4.5 V		17	42		63		53	ns
-			·	6 V		13	36		53		45	



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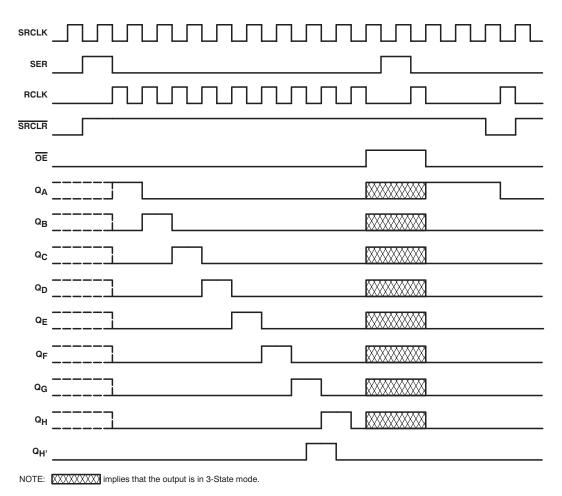


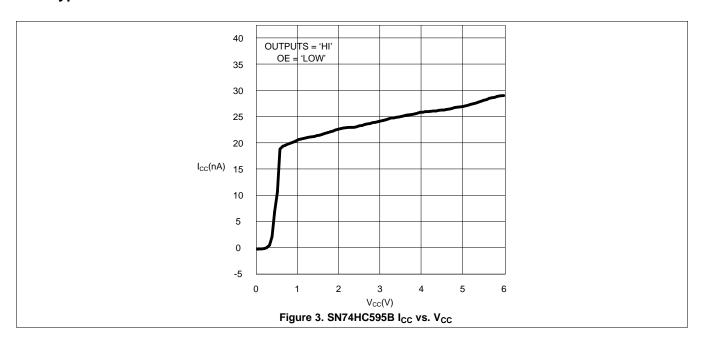
Figure 2. Timing Diagram

## 5.8 Operating Characteristics

 $T_A = 25^{\circ}C$ 

	PARAMETER	TEST CONDITIONS	TYP	UNIT
$C_{pd}$	Power dissipation capacitance	No load	400	pF

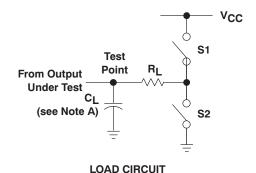
## 5.9 Typical Characteristics

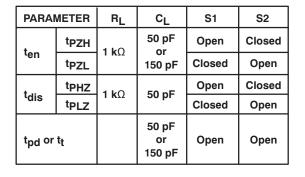


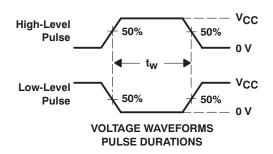


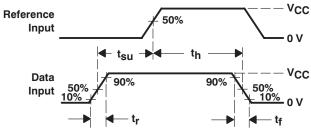
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#### Parameter Measurement Information

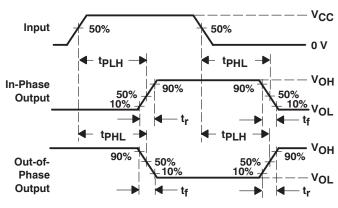


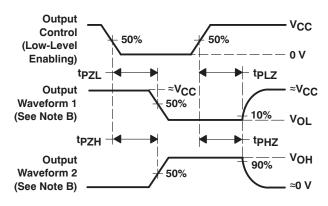






**VOLTAGE WAVEFORMS** SETUP AND HOLD AND INPUT RISE AND FALL TIMES





**VOLTAGE WAVEFORMS** PROPAGATION DELAY AND OUTPUT TRANSITION TIMES

**VOLTAGE WAVEFORMS ENABLE AND DISABLE TIMES FOR 3-STATE OUTPUTS** 

NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_f = 6 \text{ ns}$ ,  $t_f = 6 \text{ ns}$ .
- D. For clock inputs,  $f_{\mbox{\scriptsize max}}$  is measured when the input duty cycle is 50%.
- E. The outputs are measured one at a time, with one input transition per measurement.
- F. tpLz and tpHz are the same as tdis.
- G. tpzI and tpzH are the same as ten.
- H. tpLH and tpHL are the same as tpd.

Figure 4. Load Circuit and Voltage Waveforms

## 7 Detailed Description

### 7.1 Overview

The SN74HC595B is part of the HC family of logic devices intended for CMOS applications. The SN74HC595B device is an 8-bit shift register that feeds an 8-bit D-type storage register.

Both the shift register clock (SRCLK) and storage register clock (RCLK) are positive-edge triggered. If both clocks are connected together, the shift register is always one clock pulse ahead of the storage register. The Q<sub>H'</sub> may be used for daisy chaining the device and will not go into high impedance when  $\overline{OE}$  is asserted.

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7.2 Functional Block Diagram

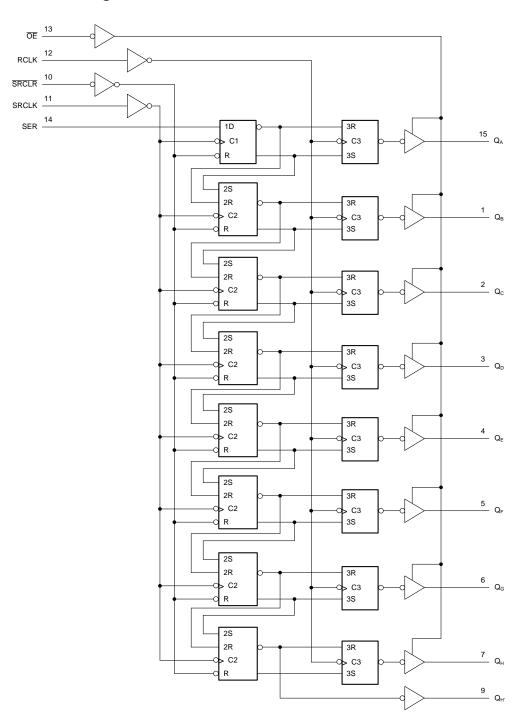


Figure 5. Logic Diagram (Positive Logic)

### 7.3 Feature Description

The SN74HC595B device is an 8-bit Serial-In, Parallel-Out shift register. It has a wide operating voltage of 2 V to 6 V, and the high-current 3-state outputs can drive up to 15 LSTTL Loads. The device has a low power consumption of 80- $\mu$ A (Maximum) I<sub>CC</sub>. Additionally, this device has a low input current of 1  $\mu$ A (Maximum) and a  $\pm$ 6-mA output drive at 5 V. The device is available currently in the smallest logic QFN package at 0.5 mm max height with 0.4 mm pitch. The inputs are over voltage tolerant independent of V<sub>cc</sub>.

### 7.4 Device Functional Modes

Table 3 lists the functional modes of the SN74HC595B devices.

**Table 3. Function Table** 

	INPUTS				FUNCTION
SER	SRCLK	SRCLR	RCLK	OE	FUNCTION
-	_	_	_	Н	Outputs $Q_A - Q_H$ are disabled. $Q_{H'}$ is active .
_	_	_	_	L	Outputs Q <sub>A</sub> – Q <sub>H</sub> are enabled.
_	_	L	_	_	Shift register is cleared.
L	1	Н	_	_	First stage of the shift register goes low. Other stages store the data of previous stage, respectively.
Н	1	Н	-	_	First stage of the shift register goes high. Other stages store the data of previous stage, respectively.
_	-	-	1	-	Shift-register data is stored in the storage register.



8 Application and Implementation

## 8.1 Application Information

The SN74HC595B is a low-drive CMOS device that is used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs.  $Q_{H'}$  pin of the first register should be connected to the serial (SER) pin of the second register for daisy chaining.

## 8.2 Typical Application

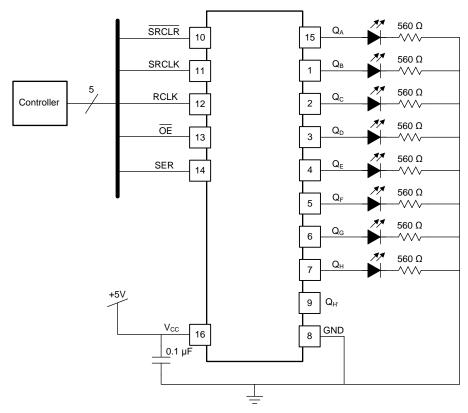


Figure 6. Typical Application Schematic

#### 8.2.1 Design Requirements

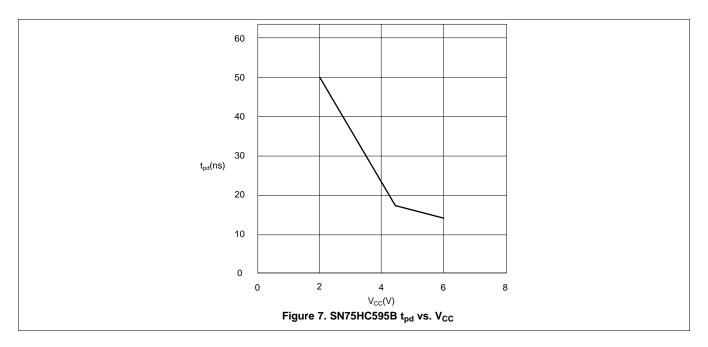
This device uses CMOS technology and has a balanced output drive. Take care to avoid bus contention because it can drive currents in excess of the maximum limits. The high drive will also create fast edges into light loads, so routing and load conditions should be considered to prevent ringing.

#### 8.2.2 Detailed Design Procedure

- · Recommended input conditions
  - Specified high and low levels. See (V<sub>IH</sub> and V<sub>IL</sub>) in the Recommended Operating Conditions table.
  - Specified high and low levels. See (VIH and VIL) in the Recommended Operating Conditions table.
  - Inputs are over-voltage tolerant allowing them to go as high as 5.5 V at any valid V<sub>CC</sub>
- · Recommended output conditions
  - Load currents should not exceed 35 mA per output as per the Absolute Maximum Ratings table.
  - Outputs should not be pulled below Ground or above V<sub>CC</sub>

## **Typical Application (continued)**

## 8.2.3 Application Curves





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## 9 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions* table. The total current through Ground or Vcc should not exceed 70 mA as per *Absolute Maximum Ratings* table.

Each  $V_{CC}$  pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1  $\mu$ f is recommended; if there are multiple  $V_{CC}$  pins, then 0.01  $\mu$ f or 0.022  $\mu$ f is recommended for each power pin. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. A 0.1  $\mu$ f and a 1  $\mu$ f are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

## 10 Layout

### 10.1 Layout Guidelines

When using multiple-bit logic devices, inputs should never float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input and the gate are used, or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Figure 8 specifies the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally, they will be tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient. It is acceptable to float outputs, unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the output section of the part when asserted. This will not disable the input section of the I/Os, so they cannot float when disabled.

### 10.2 Layout Example

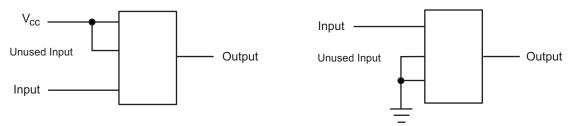


Figure 8. Layout Diagram

### 11 器件和文档支持

#### 11.1 文档支持

#### 11.1.1 相关文档

相关文档如下:

《CMOS 输入缓慢变化或悬空的影响》,SCBA004

### 11.2 社区资源

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.3 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

## 11.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 11.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 12 机械、封装和可订购信息

以下页中包括机械封装和可订购信息。这些信息是针对指定器件可提供的最新数据。这些数据会在无通知且不对本 文档进行修订的情况下发生改变。要获得这份数据表的浏览器版本,请查阅左侧导航栏。 www.ti.com 23-May-2025

#### PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package   Pins	Package qty   Carrier	<b>RoHS</b> (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
SN74HC595BRWNR	Active	Production	X1QFN (RWN)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	13YI
SN74HC595BRWNR.B	Active	Production	X1QFN (RWN)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	13YI
SN74HC595BRWNRG4.B	Active	Production	X1QFN (RWN)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	13YI

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

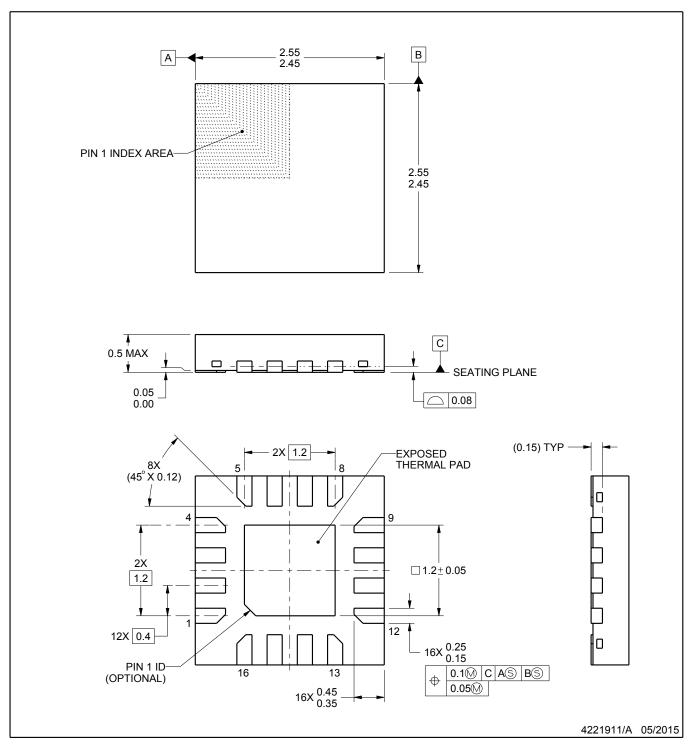
<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



PLASTIC QUAD FLATPACK - NO LEAD

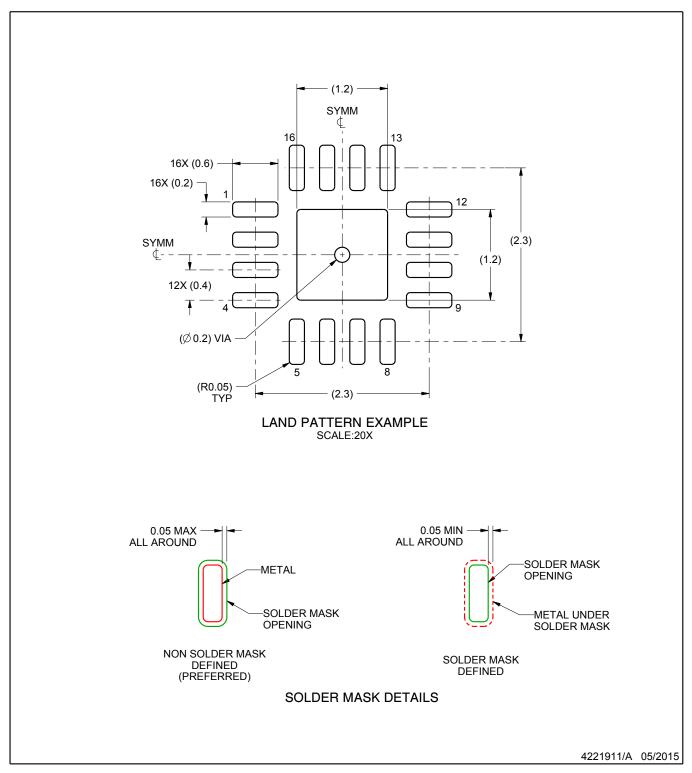


#### NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK - NO LEAD

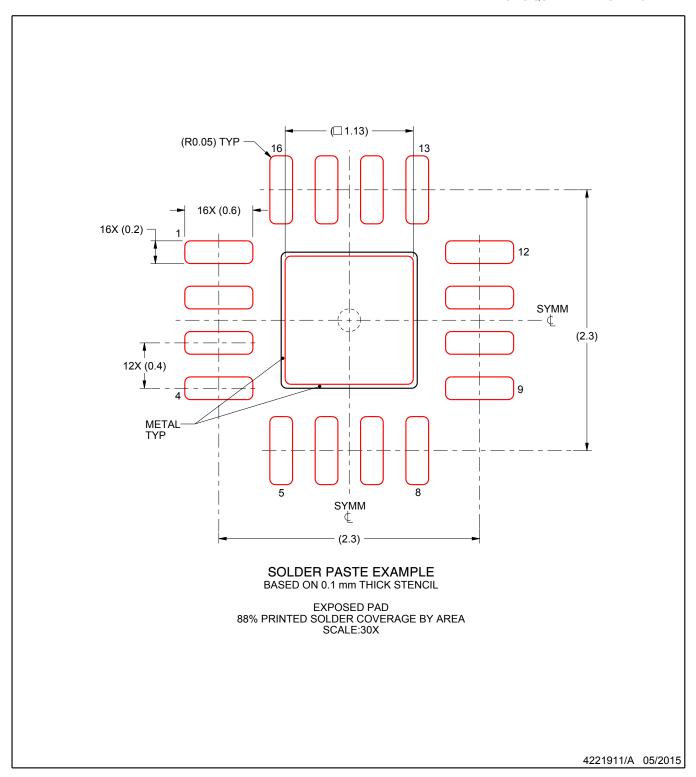


NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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